

Search Notes

Application/Control No.

10/070,795

Examiner

Ted M. Wang

Applicant(s)/Patent under
Reexamination

LIPP, FRIEDRICH

Art Unit

2634

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|----------|----------|
| 375 | 308 | 6/3/2005 | 7-8 |
| | 297 | | |
| | 219 | | |
| | 296 | | |
| | 279 | | |
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| 330 | 2 | | |
| | 129 | | |
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| 455 | 126 | | |
| | 78 | | |
| | 69 | | |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
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| EAST & IEEE Xplor | 6/3/2005 | 7-8 |
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